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Test Report						
Test Report No.:	KTI09EF12002					
Registration No.:	99058	99058				
Applicant:	UNIONCOMMUNITY					
Applicant Address:	3F, Hyundai Topics Bldg., 44	4-3, Bangi-dong, Sc	ongpa-gu, Seoul,			
	138-050, Korea					
Product:	Fingerprint Identification Te	rminal				
FCC ID:	XX2-VIRDI4000SC	Model No.	VIRDI 4000SC, LAFP10-S			
Receipt No.:	09-1149	Date of receipt:	November 23, 2009			
Date of Issue:	December 01, 2009					
Testing location	Korea Technology Institute	Co., Ltd.				
	51-19, Sanglim3-Ri, Docheo	k-Myeun, Gwangju	-Shi, Gyeungki-Do, Korea			
Test Standards:	FCC/ANSI. C63.4: 2003					
Rule Parts: FCC	Part 15, Class B					
Equipment Class:	Digital device					
Test Result:	The above-mentioned produ	uct has been tested	with compliance.			
Tested by:	T.W. Lee	Approved	l by: G. C. Min /President			
	/ Engineer		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,			
ol	solo la	Ģ	Crlin			
Signature	Date	Signatur	e Date			
Other Aspects:						
Abbreviations:	* OK, Pass=passed * Fail=	failed * N/A=not	applicable			
- This test report is	s not permitted to copy partly	without our permis	sion.			
- This test result is	dependent on only equipmen	it to be used.				
	based on a single evaluation	-				
- This test report must not be used by the client to claim product endorsement by NVLAP or						
any agency of the U.S Government.						
 We certify this test report has been based on the measurement standards that is traceable to the national or international standards. 						
the national of it	iternational Stanuarus.					

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1. General

This equipment has been shown to be capable of compliance with the applicable technical standards and was tested in accordance with the measurement procedures as indicated in this report.

We attest to the accuracy of data. Korea Technology Institute Co., Ltd. performed all measurements reported herein. And were made under Chief Engineer's supervisor. We assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

2. Test Site

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Location

51-19, Sanglim3-Ri, Docheok-Myeun, Gwangju-Shi, Gyeungki-Do, Korea

The Test Site is in compliance with ANSI C63.4/2003 for measurement of radio Interference.



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List of Test and Measurement Instruments

Table 1: List of Test and Measurement Equipment

- Conducted Emissions

Kind of Equipment	Туре	S/N	Calibrated until
Field Strength Meter	ESIB40	100093	08.2010
LISN	KNW407	8-1157-2	05.2010
LISN	EM-7823	115019	05.2010
Conducted Cable	N/A	N/A	11.2010

- Radiated Emissions

Kind of Equipment	Туре	S/N	Calibrated until
Field Strength Meter	ESIB40	100093	08.2010
Loop Antenna	6502	3434	03.2010
Biconic Logarithmic Periodic Antenna	VULB9163	9163-281	10.2010
Horn Antenna	3115	6443	03.2010
Open Site Cable	N/A	N/A	11.2010
Antenna Master	DETT-03	N/A	N / A
Antenna & Turntable controller	DETT-04	91X519	N/A

Test Date

Date of Application: November 23, 2009 Date of Test: November 25, 2009

Test Environment

Indoor: 21 °C/40%/1000mbar Outdoor: 9.7 °C/23%/1000mbar



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3. Description of the tested samples

The EUT is Fingerprint Identification Terminal.

Rating and Physical Characteristics

ITEM1	ITEM2	Spec.
	Max. User	30,000 Persons
	Identification time	Under 1sec at 1:1,000 Template
	Live Finger Detector	Detecting Pafer, Film, Rubber, Silicon, etc
Finger Print Part	FRR/ FAR	0.01%/ 0.001%
	FP Sensor Type	Optical
	Auto Sensing	Applied
DE Card Dart	SC Option Model	13.56 MHz A Type Module
RF Card Part	Reading Distance	Smart Card : 2.5 cm
	Connect to PC Server or	10 Base-T Ethernet
Communication Part	Other Device	RS232, RS485, Wiegand IN/OUT
Pan	Wiegand Protocol	26 bit / 34 bit Standard
	Electric Lock Control	Dead-Bolt, EM, Strike, Motor Lock, Auto Door
	LCD Display	128x64 Graphic LCD w/white Back-Light
	Ten Key	3x4 Keypad Matrix
	Function Button	F1~F4 Button
Output Part	Call Button	Call Button for a Door Phone
	LED Display	Blue & Red LED
	Voice	Output Voice Information on 1W Speaker
	Buzzer	Output Buzzer Beep
		INPUT: Universal AC 100~220V
Supply Voltage	AC/DC Adaptor	OUTPUT: DC 12V(Max. 5.5W)
		EK, UL, CSA, CE Approved
Operating Temp.		-10 °C ~ +50 °C
Dimensions		181 X 109 X 47 mm [Width x Height x Depth]

Submitted Documents

- User's Guide
- Block Diagram



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4. Measurement Conditions

Testing Input Voltage: AC 220V

Modes of Operation

The EUT was in the following operation mode during all testing;

Prior to a measurement, the Instruments of education shall be operated until stabilization has been reached.

Additional Equipment

DEVICE TYPE	Manufacturer	M/N	S/N	FCC ID
PC	COMPAQ	EvoD5M	6F28KN8ZH110	DOC
Monitor	DELL	1704FPTt	7735428790POE	DOC
Keyboard	COMPAQ	SK-2880	B943C0ADPS0ZL	DOC
Mouse	Logitech	M-UV96	265986-003	DOC
Door Lock	BEHOST	BHL-700C	N / A	DOC
Adaptor	I.T.E. Power Supply	JPW128KA1200F03	N / A	DOC
Ferrite Core *	TDK	ZCAT Series	ZCAT1730-0730A	-

* This Ferrite core will be provided as standard equipment by the Manufacturer of this EUT

Uncertainty

1) Radiated disturbance

Uc (Combined standard Uncertainty) = \pm 1.8dB

Expanded uncertainty U=KUc

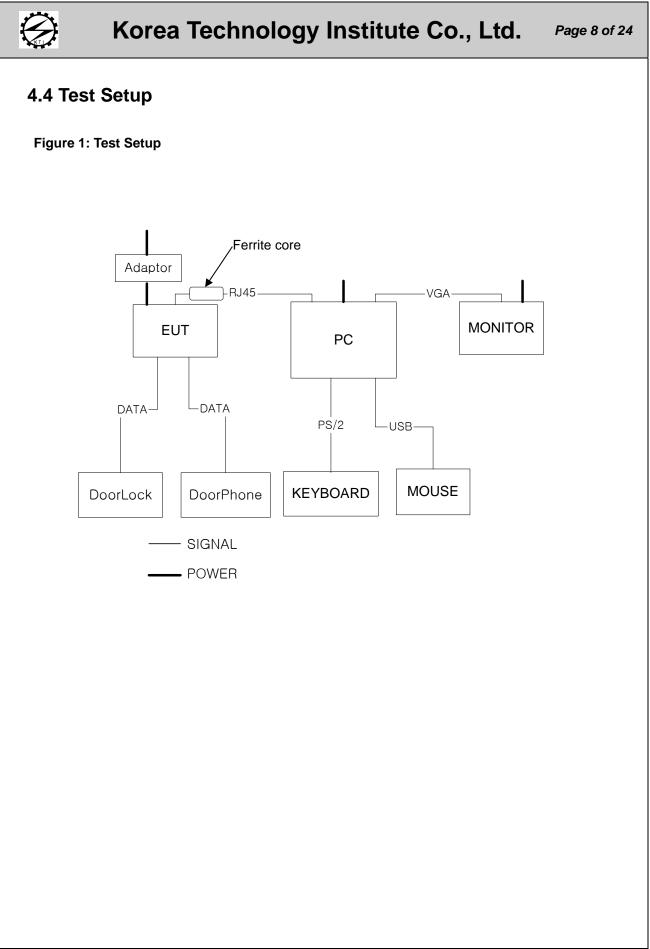
K = 2

 \therefore U = ± 3.6dB

2) Conducted disturbance

 $Uc = \pm 0.88dB$

 $U = KUc=2 \times Uc = \pm 1.8 dB$





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5. TEST AND MEASUREMENTS

Summary of Test Results

Requirement	FCC, 47CFR15	Report Section	Test Result
Antenna Requirement	15.203	5.1	PASS
Conducted Emissions			
Radiated Emissions	15.209 & 15.205	5.2	DASS
Field strength 9 kHz to 30 MHz	15.209 & 15.205	5.2	PASS
Field strength 30 MHz to 1000 MHz			
Spectrum mask and Occupied bandwidth	15.225(a),(b),(c)	5.2	DACC
	& (d)	5.3	PASS
Frequency Tolerance of the Carrier Signal	15.225(e)	5.4	PASS

* According to the Section 15.33(b)(1)&(c), Radiated Emissions & Conducted Emissions were reported in Report No. KTI09EF12005.

5.1 ANTNNA REQUIRMENT

5.1.1 Regulation

FCC 47CFR15 - 15.203

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this Section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. This requirement does not apply to carrier current devices or to devices operated under the provisions of Sections 15.211, 15.213, 15.217, 15.219, or 15.221. Further, this requirement does not apply to intentional radiators that must be professionally installed, such as perimeter protection systems and some field disturbance sensors, or to other intentional radiators which, in accordance with Section 15.31(d), must be measured at the installation site. However, the installer shall be responsible for ensuring that the proper antenna is employed so that the limits in this Part are not exceeded.

5.1.2 Result:

PASS

The transmitter has an integral PCB loop antenna that is enclosed within the housing of the EUT, and meets the requirements of this section.



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5.2 EMISSION TEST

5.2.1.Conducted Emissions

Result:

The line-conducted facility is located inside a 2.3M x 3.5M x 5.5M shielded closure.

The shielding effectiveness of the shielded room is in accordance with MIL-Std-285 or NSA 605-05. A 1m x 1.5m wooden table 80cm high is placed 80cm away from the conducting ground plane and 40cm away from the sidewall of the shielded room. Electro-Metroics Model EM-7823 (9kHz-30MHz)50ohm/50 uH Line-Impedance Stabilization Networks (LISN) are bonded to the shielded room.

The EUT is powered from the Electro-Metroics LISN and the support equipment is powered from the Kyoritsu LISN. Power to the LISN are filtered by a high-current high-insertion loss shield enclosures power line filters (100dB 14kHz-1GHz).

The purpose of the filter is to attenuate ambient signal interference and this filter is also bonded to the shielded enclosure.

All electrical cables are shielded by copper pipe with inner diameter of 1".

If the EUT is a DC-Powered device, power will be derived from the source power supply it normally will be powered from and this supply lines will be connected to the Rohde & Schwarz LISN.

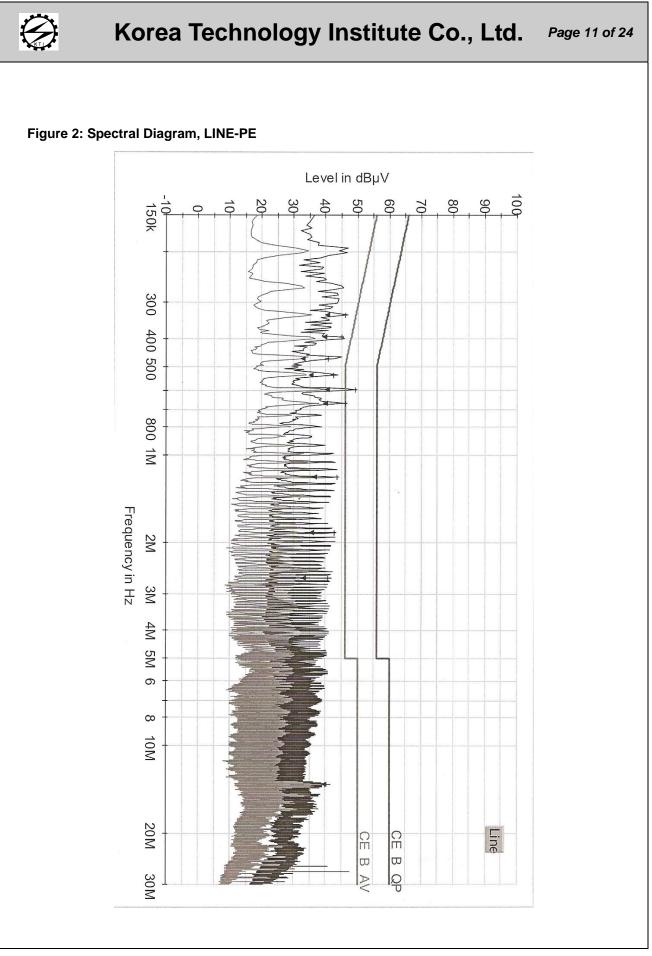
All interconnecting cables more than 1 meter were shortened by non-inductive bundling (serpentine fashion) to a 1-meter length.

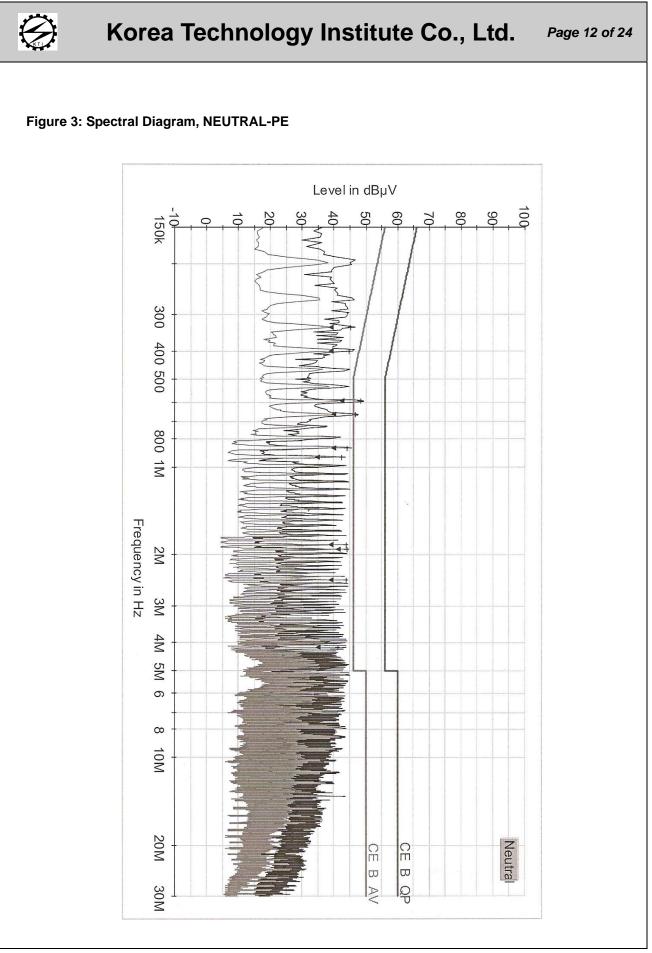
Sufficient time for the EUT, Support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the spectrum analyzer to determine the frequency producing the maximum EME from the EUT. The frequency producing the maximum level was reexamined using EMI field Intensity meter (ESIB40). The detector function was set to CISPR quasi-peak mode.

The bandwidth of the receiver was set to 10kHZ. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Each emission was maximized by: switching power lines; varying the mode of operation or resolution; clock or data exchange speed; if applicable; whichever determined the worst-case emission. Photographs of the worst-case emission can be seen in photograph of conducted test.

Each EME reported was calibrated using self-calibrating mode.

Pass







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Frequency	. ,	ading µV)	Line	(2) Limit (dBµV)		(3) Margin (dB)	
(MHz)	QP	AV		QP	AV	QP	AV
0.33	46.28	40.53	L1	59.45	49.45	13.17	8.92
0.39	45.05	36.61	L1	58.06	48.06	13.01	11.45
0.59	48.52	41.85	L2	56.00	46.00	7.48	4.15
0.60	49.34	40.57	L1	56.00	46.00	6.66	5.43
0.66	48.88	39.72	L2	56.00	46.00	7.12	6.28
0.86	44.15	40.06	L2	56.00	46.00	11.85	5.94

Table 2: Test Data, Conducted Emissions

NOTES:

1. All modes of operation were investigated

And the worst-case emissions are reported.

- 2. All other emissions are non-significant.
- 3. All readings are calibrated by self-mode in receiver.
- 4. Measurements using CISPR quasi-peak mode.
- 5. L1 = LINE-PE, L2 = NEUTRAL-PE
- 6. The limit for Class B digital device is 66dBuV to 56dBuV from 150KHz to 500KHz, 56dBuV from 500KHz to 5MHz, 60dBuV Above 5MHz.

Margin Calculation

(3) Margin = (2) Limit – (1) Reading



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5.2.2 Radiated Emissions

5.2.2.1 Regulation

FCC 47CFR15 - 15.209

(a)Except as provided elsewhere in this Subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Frequency	Field strength limit	Field strength limit	Measurement
(MHz)	(uV/m)	(dBuV/m)	Distance (m)
0.009 - 0.490	2400/F(kHz)	48.5-13.8	300
0.490 – 1.705	24000/F(kHz)	33.8-23.0	30
1.705 – 30.0	30	29.5	30
30 - 88	100	40.0	3
88 – 216	150	43.5	3
216 – 960	200	46.0	3
Above 960	500	54.0	3

5.2.2.2 Measurement Procedure

Radiated Emissions Test, 9kHz to 30MHz (Magnetic Field Test)

- 1. The preliminary radiated measurements were performed to determine the frequency producing the maximum emissions at a distance of 3 meters according to Section 15.31(f)(2).
- 2. The EUT was placed on the top of the 0.8-meter height, 1 x 1.5 meter non-metallic table.
- 3. Emissions from the EUT are maximized by adjusting the orientation of the Loop antenna and rotating the EUT on the turntable. Manipulating the system cables also maximizes EUT emissions if applicable.
- 4. To obtain the final measurement data, each frequency found during preliminary measurements was re-examined and investigated. The test-receiver system was set up to average, peak, and quasi-peak detector with specified bandwidth.



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Radiated Emissions Test, 30 MHz to 1000 MHz

- 1. The preliminary radiated measurements were performed to determine the frequency producing the maximum emissions in an anechoic chamber at a distance of 3 meters.
- 2. The EUT was placed on the top of the 0.8-meter height, 1 x 1.5 meter non-metallic table. To find the maximum emission levels, the height of a measuring antenna was changed and the turntable was rotated 360
- 3. The antenna polarization was also changed from vertical to horizontal. The spectrum was scanned from 30 to 1000 MHz using the Biconical and Logperiodue broadband antenna,
- 4. To obtain the final measurement data, the EUT was arranged on a turntable situated on a 4 x 4 meter at the Open Area Test Site. The EUT was tested at a distance 3 meters.
- 5. Each frequency found during preliminary measurements was re-examined and investigated. The test-receiver system was set up to average, peak, and quasi-peak detector function with specified bandwidth.
- 6. The presence of ambient signals was verified by turning the EUT off. In case an ambient signal was detected, the measurement bandwidth was reduced temporarily and verification was made that an additional adjacent peak did not exist. This ensures that the ambient signal does not hide any emissions from the EUT

5.2.2.3 Calculation of the field strength limits below 30 MHz

- 1. No special calculation for obtaining the field strength in dBuV/m is necessary, because the EMI receiver and the active loop antenna operate as a system, where the reading gives directly the field strength result (dBuV/m). The antenna factors and cable losses are already taken into consideration.
- For test distance other than what is specified, but fulfilling the requirements of section 15.31 (f)(2) the field strength is calculated by adding additionally an extrapolation factor of 40dB/decade (inverse linear distance for field strength measurements).
- 3. All following emission measurements were performed using the test receiver's average, peak, and quasi-peak detector function with specified bandwidth.



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5.2.2.4 Test Results (Test mode : TX on)

PASS

Table 3: Test Data, Fundamental Frequency (Ver / Hor)

Frequency (MHz)	Pol.	Reading (dBµV)	AFCL (dB/m)	Actual (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Detector
13.560	V	43.68	9.94	53.62	124	70.38	QP
13.560	V	43.87	9.94	53.81	-	-	AV

Frequency (MHz)	Pol.	Reading (dBµV)	AFCL (dB/m)	Actual (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Detector
13.560	н	38.95	9.94	48.89	124	75.11	QP
13.560	Н	39.16	9.94	49.10	-	-	AV

FCC 47CFR15 - 15.209 (9 kHz - 30 MHz)

 Table 4: Test Data, Radiated Emission below 30 MHz

Frequency (MHz)	Pol.	Height [m]	Angle [°]	(1) Reading (dBµV)	(2) AFCL (dB/m)	(3) Actual (dBµV/m)	(4) Limit (dBµV/m)	(5) Margin (dB)
0.724	V	1.25	180	24.56	11.56	36.12	70.41	34.29
2.548	V	1.28	179	21.13	11.12	32.25	69.54	37.29
9.424	V	1.29	181	22.43	10.26	32.69	69.54	36.85
13.136	н	1.41	274	5.27	10.04	15.31	69.54	54.23
13.988	V	1.41	182	10.63	9.99	20.62	69.54	48.92
20.260	н	1.53	271	7.66	9.35	17.01	69.54	52.53

Margin (dB) = Limit – Actual [Actual = FS + AF + CL]

1.H = Horizontal, V = Vertical Polarization

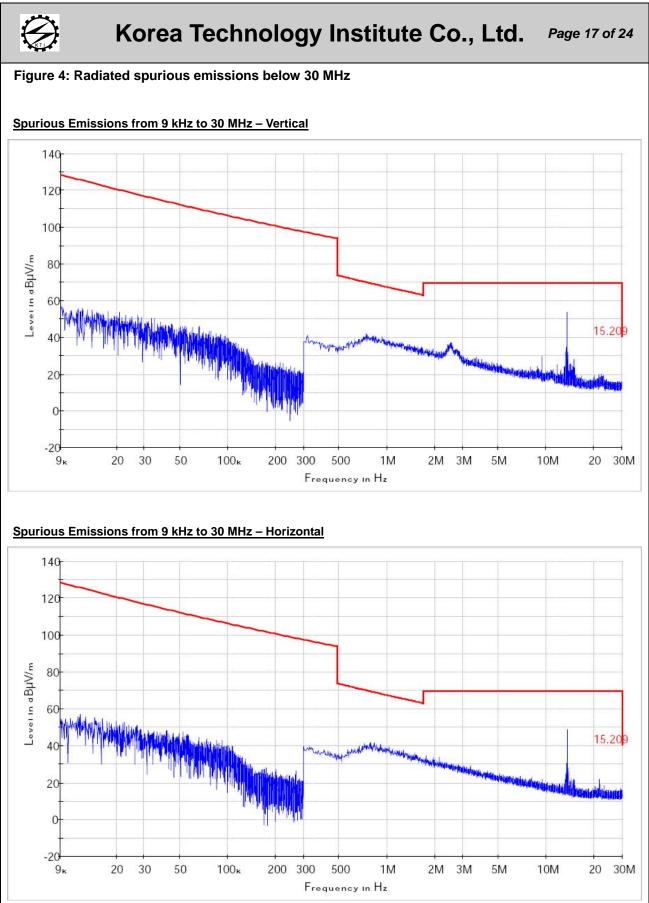
2.AF/CL = Antenna Factor and Cable Loss

3.FS = RA + DF

Where FS = Field strength in dBuV/m

RA = Reciever Amplitude in dBuV/m

DF = Distance Extrapolation Factor in dB





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5.2.2.5 Calculation of the field strength limits above 30 MHz

1. No special calculation for obtaining the field strength in dBuV/m is necessary, because the EMI receiver and the active loop antenna operate as a system, where the reading gives directly the field strength result (dBuV/m). The antenna factors and cable losses are already taken into consideration.

2. For test distance other than what is specified, but fulfilling the requirements of section 15.31 (f)(2) the field strength is calculated by adding additionally an extrapolation factor of 40dB/decade (inverse linear distance for field strength measurements).

3. All following emission measurements were performed using the test receiver's average, peak, and quasi-peak detector function with specified bandwidth.

5.2.2.6 Test Results (Test mode : TX on)

PASS

FCC 47CFR15 – 15.209

Table 5: Test Data, Radiated Emission above 30 MHz

Frequency	Del	Height	Angle	Reading	AFCL	Actual	Limit	Margin
(MHz)	Pol.	[m]	[°]	(dBµV)	(dB/m)	(dBµV/m)	(dBµV/m)	(dB)
230.56	Н	1.62	181	18.26	12.55	30.81	46.0	15.19
311.92	Н	1.64	181	15.85	14.63	30.48	46.0	15.52
532.08	Н	1.68	180	14.71	19.11	33.82	46.0	12.18
772.36	Н	1.73	177	12.57	23.12	35.69	46.0	10.31
798.16	Н	1.75	177	13.50	23.20	36.70	46.0	9.30
931.12	V	1.92	169	8.17	25.14	33.31	46.0	12.69

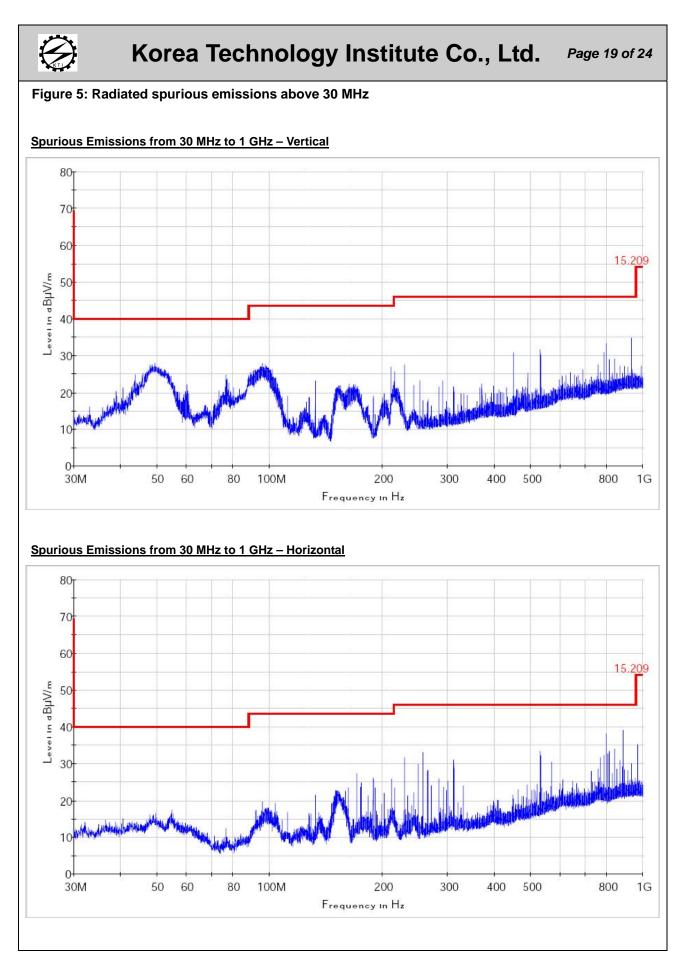
FCC 47CFR15-15.205 Restricted Band

Frequency	Del	Height	Angle	Reading	AFCL	Actual	Limit	Margin
(MHz)	Pol.	[m]	[°]	(dBµV)	(dB/m)	(dBµV/m)	(dBµV/m)	(dB)
123.28	н	1.51	181	15.90	10.42	26.32	43.5	17.18
133.00	V	1.55	181	12.87	9.42	22.29	43.5	21.21
257.68	Н	1.65	183	19.74	13.20	32.94	46.0	13.06
265.96	Н	1.65	183	14.57	13.46	28.03	46.0	17.97
284.80	н	1.69	173	11.68	13.89	25.57	46.0	20.43
325.48	Н	1.73	176	10.38	15.12	25.50	46.0	20.50

Margin (dB) = Limit – Actual [Actual = Reading + AF + CL]

1.H = Horizontal, V = Vertical Polarization

2.AF/CL = Antenna Factor and Cable Loss



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5.3 Spectrum mask and Occupied bandwidth

5.3.1 Regulation

FCC 47CFR15 - 15.225

- (a) The field strength of any emissions within the band 13.553-13.567 MHz shall not exceed 15,848 microvolts/meter at 30 meters.
- (b) Within the bands 13.410-13.553 MHz and 13.567-13.710 MHz, the field strength of any emissions shall not exceed 334 microvolts/meter at 30 meters.
- (c) Within the bands 13.110-13.410 MHz and 13.710-14.010 MHz the field strength of any emissions shall not exceed 106 microvolts/meter at 30 meters.
- (d) The field strength of any emissions appearing outside of the 13.110-14.010 MHz band shall not exceed the general radiated emission limits in § 15.209.

Frequency	equency Field strength limit		Field strength limit
(MHz)	(uV/m) @ 30m	(dBuV/m) @ 30m	(dBuV/m) @ 3m
13.110 – 13.410	106	40.5	80.5
13.410 – 13.553	334	50.5	90.5
13.553 – 13.567	15,848	84.0	124.0
13.567 – 13.710	3.567 – 13.710 334		90.5
13.710 – 14.010	106	40.5	80.5

5.3.2 Measurement Procedure

Spectrum Mask

1. Place the EUT in the text fixture and switch it on

2. Use the following spectrum analyzer settings: RBW = VBW = 1 kHz, Span = wide enough to capture the whole 13 MHz band including the frequency ranges were the 15.209 limit applies, Trace mode = Max Hold, select the limit line 15.225(a),(b),(c)

- 3. After trace stabilization, set the marker to the single peak.
- 4. The reference level will be calculated by the amount of the margin of the wanted signal to its 30 m emission limit plus marker value.
- 5. The whole signal trace has to be below the limit line.

PASS



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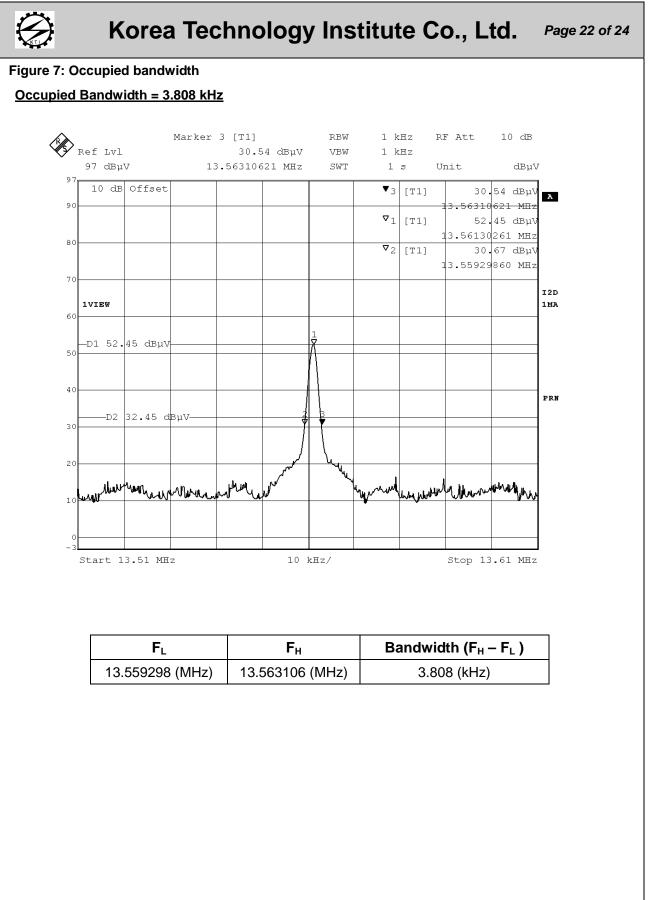
Occupied Bandwidth

- 1. Place the EUT in the text fixture and switch it on.
- 2. Use the following spectrum analyzer settings: RBW = VBW =10 kHz, Span = wide enough to capture the 20 dB bandwidth, Trace mode = Max Hold.
- 3. After trace stabilization, set the first marker and the first display line to the signal peak. Set the second display line 20 dB below the first display line. The Second marker and its delta marker shall be set to cross point of the spectrum line and the second display line and note these frequencies.
- 4. Alternatively the 20 dB down function of the analyzer could be used, if this function will be applicable to the displayed spectrum.

5.3.3 Test Results (Test mode : Modulated)

Marker 1 [T1] RBW 1 kHz RF Att 30 dB Ref Lvl 51.94 dBµV ∇BW 1 kHz 125 dBµV 13.56100200 MHz SWT 2.5 s Unit dBuV 12! 10 dB Offset ▼1 [T1] 51.94 dBu A 120 13.56100200 MHz 110 100 I2D 1MA 1VIEW 9.0 80 70 SP_MAS PRN 60 50 40 30 Julian a for a share of the second of the Start 13.06 MHz 100 kHz/ Stop 14.06 MHz

Figure 6: Spectrum Mask



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5.4 FREQUENCY TOLERANCE OF CARRIER SIGNAL

5.4.1 Regulation

FCC 47CFR15 - 15.225(e)

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of –20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. For battery-operated equipment, the equipment tests shall be performed using a new battery.

5.4.2 Measurement Procedure

Frequency stability versus environmental temperature

1.Supply the EUT with nominal DC voltage.

- 2.Turn the EUT off, and place it inside an environmental temperature chamber. For devices that are normally operated continuously, the EUT may be energized while inside the test chamber. For devices that have oscillator heaters, energize only the heater circuit while the EUT is inside the chamber.3.RF output was connected to a frequency counter or other frequency-measuring instrument via feed
- through attenuators.
- 4.Set the temperature control on the chamber to the highest specified EUT operating temperature, and allow the temperature inside the chamber to stabilize at the set temperature before starting frequency measurements.
- 5.While maintaining a constant temperature inside the environmental chamber, turn the EUT on and record the operating frequency at startup and two, five, and ten minutes after the EUT is energized.
- 6.After all measurements have been made at the highest specified temperature turn the EUT off.
- 7.Repeat the above measurement process for the EUT with the test chamber set at the appropriate temperature.

Frequency Stability versus Input Voltage

- 1.At temperature (20 $~\pm~5^{\circ}\text{C}),$ supply the EUT with nominal DC voltage.
- 2.Couple RF output to a frequency counter or other frequency-measuring instrument.
- 3. Turn the EUT on, and measure the EUT operating frequency at startup and two, five, and ten minutes after startup.
- 4. Supply it with 85% of the nominal DC voltage and repeat above procedure.
- 5. Supply it with 115% of the nominal DC voltage and repeat above procedure.

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5.4.3 Test Results :

PASS

TEST MODE : TX on

Table 6: Tes	Table 6: Test Data, Frequency Tolerance of carrier signal											
	Reference Frequency : 13.56 MHz, LIMIT : within \pm 1356 Hz											
Environment	Power		Ca	rrier Freque	ency Meas	ured with T	ime Elaps	ed				
Temperature	Supplied	STAF	RTUP	2 mir	nutes	5 mir	nutes	10 mir	nutes			
[°C]	[V _{AC}]	[MHz]	Err[Hz]	[MHz]	Err[Hz]	[MHz]	Err[Hz]	[MHz]	Err[Hz]			
+50	220	13.560013	13	13.560011	11	13.560015	15	13.560018	18			
+40	220	13.560046	46	13.560017	17	13.560015	15	13.560015	15			
+30	220	13.560043	43	13.560032	32	13.560024	24	13.560021	21			
+20	220	13.560103	103	13.560085	85	13.560057	57	13.560057	57			
+10	220	13.560126	126	13.560090	90	13.560085	85	13.560080	80			
0	220	13.560141	141	13.560125	125	13.560119	119	13.560111	111			
-10	220	13.560177	177	13.560145	145	13.560140	140	13.560138	138			
-20	220	13.560165	165	13.560152	152	13.560147	147	13.560147	147			

Reference Frequency : 13.56 MHz, LIMIT : within \pm 1356 Hz

Power		Carrier Frequency Measured with Time Elapsed							
Supplied	STARTUP		2 minutes		5 minutes		10 minutes		
[V _{AC}]	[MHz]	Err[Hz]	[MHz]	Err[Hz]	[MHz]	Err[Hz]	[MHz]	Err[Hz]	
85 %	13.560084	84	13.560064	64	13.560054	54	13.560049	49	
100 %	13.560082	82	13.560063	63	13.560043	43	13.560037	37	
115 %	13.560069	69	13.560049	49	13.560038	38	13.560036	36	

Err[Hz] = Measured carrier frequency (MHz) – Reference Frequency (13.56 MHz)